



# **Phase Control Thyristor**

DS5933-4 April 2013 (LN30253)

### **FEATURES**

- Double Side Cooling
- High Surge Capability

### **APPLICATIONS**

- High Power Drives
- High Voltage Power Supplies
- Static Switches

#### **VOLTAGE RATINGS**

Part and Ordering Number	Repetitive Peak Voltages V <sub>DRM</sub> and V <sub>RRM</sub> V	Conditions
DCR3220A65* DCR3220A60 DCR3220A55	6500 6000 5500	$\begin{split} &T_{vj} = \text{-}40^{\circ}\text{C to 125}^{\circ}\text{C}, \\ &I_{DRM} = I_{RRM} = 300\text{mA}, \\ &V_{DRM}, V_{RRM}  t_p = 10\text{ms}, \\ &V_{DSM}  \&  V_{RSM} = \\ &V_{DRM}  \&  V_{RRM} + 100V \\ &\text{respectively} \end{split}$

Lower voltage grades available. \*6200V @ -40°C, 6500V @ 0°C

### **ORDERING INFORMATION**

When ordering, select the required part number shown in the Voltage Ratings selection table.

For example:

## DCR3220A65

Note: Please use the complete part number when ordering and quote this number in any future correspondence relating to your order.

# **KEY PARAMETERS**

$V_{DRM}$	6500V
$I_{T(AV)}$	3310A
I <sub>TSM</sub>	44200A
dV/dt*	2000V/µs
dl/dt	200A/μs
	<del>-</del>

\* Higher dV/dt selections available

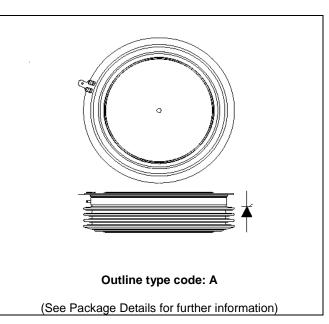


Fig. 1 Package outline





# **CURRENT RATINGS**

# $T_{\text{case}}$ = 60°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
Double Si	de Cooled			
I <sub>T(AV)</sub>	Mean on-state current	Half wave resistive load	3220	А
I <sub>T(RMS)</sub>	RMS value	-	5058	А
I <sub>T</sub>	Continuous (direct) on-state current	-	4655	А

# **SURGE RATINGS**

Symbol Parameter		Test Conditions	Max.	Units
I <sub>TSM</sub>	Surge (non-repetitive) on-state current	10ms half sine, $T_{case} = 125$ °C	43.0	kA
l <sup>2</sup> t	I <sup>2</sup> t for fusing	$V_R = 0$	9.25	MA <sup>2</sup> s

# THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions		Min.	Max.	Units
R <sub>th(j-c)</sub>	Thermal resistance – junction to case	Double side cooled DC		-	0.00603	°C/W
		Single side cooled	Anode DC	-	0.01024	°C/W
			Cathode DC	-	0.01467	°C/W
R <sub>th(c-h)</sub>	Thermal resistance – case to heatsink	Clamping force 83.0kN Double side		-	0.001	°C/W
		(with mounting compound)	Single side	-	0.002	°C/W
T <sub>vj</sub>	Virtual junction temperature	Blocking V <sub>DRM</sub> / V <sub>RRM</sub>		-	125	°C
T <sub>stg</sub>	Storage temperature range			-55	125	°C
F <sub>m</sub>	Clamping force			74.0	91.0	kN





# **DYNAMIC CHARACTERISTICS**

Symbol	Parameter	Test Conditions		Min.	Max.	Units
I <sub>RRM</sub> /I <sub>DRM</sub>	Peak reverse and off-state current	At V <sub>RRM</sub> /V <sub>DRM</sub> , T <sub>case</sub> = 125°C	At V <sub>RRM</sub> /V <sub>DRM</sub> , T <sub>case</sub> = 125°C		300	mA
dV/dt	Max. linear rate of rise of off-state voltage	To 67% $V_{DRM}$ , $T_j = 125$ °C, ga	ate open	-	2000	V/µs
dl/dt	Rate of rise of on-state current	From 67% V <sub>DRM</sub> to 2x I <sub>T(AV)</sub>	Repetitive 50Hz	-	200	A/µs
		Gate source 30V, 10Ω,	Non-repetitive	-	500	A/µs
		$t_r < 0.5 \mu s, T_j = 125 ^{\circ} C$				
V <sub>T(TO)</sub>	Threshold voltage – Low level	500 to 1900A at T <sub>case</sub> = 125°	С	-	1.01	V
	Threshold voltage – High level	1900 to 6000A at T <sub>case</sub> = 125	°C	-	1.08	V
r <sub>T</sub>	On-state slope resistance – Low level	500A to 1900A at T <sub>case</sub> = 125°C		-	0.3	mΩ
	On-state slope resistance – High level	1600A to 6000A at T <sub>case</sub> = 125°C		-	0.2643	mΩ
t <sub>gd</sub>	Delay time	$V_D = 67\% V_{DRM}$ , gate source 30V, $10\Omega$		-	3	μs
		$t_r = 0.5 \mu s, T_j = 25^{\circ}C$				
tq	Turn-off time	$I_T = 3000A$ , $T_j = 125$ °C, $V_R = 200V$ , $dI/dt = 1A/\mu s$ ,			500	μs
		dV <sub>DR</sub> /dt = 20V/μs linear				
Qs	Stored charge	1 - 2000 A T - 125°C dl/dt 10/40		3830	6430	μC
I <sub>RR</sub>	Reverse recovery current	- $I_T = 3000A$ , $T_j = 125^{\circ}C$ , $dI/dt - 1A/\mu s$ , $V_{Rpeak} \sim 3900V$ , $V_R \sim 2600V$		45	60	А
IL	Latching current	$T_j = 25$ °C, $V_D = 5V$		-	3	А
IH	Holding current	$T_j = 25^{\circ}\text{C}, \ R_{G-K} = \infty, \ I_{TM} = 500\text{A}, \ I_T = 5\text{A}$		-	300	mA





### **GATE TRIGGER CHARACTERISTICS AND RATINGS**

Symbol	Parameter	Test Conditions	Max.	Units
$V_{GT}$	Gate trigger voltage	V <sub>DRM</sub> = 5V, T <sub>case</sub> = 25°C	1.5	V
$V_{GD}$	Gate non-trigger voltage	At 50% V <sub>DRM</sub> , T <sub>case</sub> = 125°C	0.4	V
I <sub>GT</sub>	Gate trigger current	V <sub>DRM</sub> = 5V, T <sub>case</sub> = 25°C	400	mA
I <sub>GD</sub>	Gate non-trigger current	At 50% V <sub>DRM</sub> , T <sub>case</sub> = 125°C	10	mA

# **CURVES**

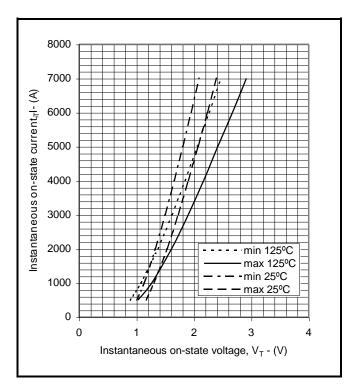


Fig.2 Maximum & minimum on-state characteristics

 $V_{\text{TM}}$  EQUATION

Where A = -0.645429B = 0.3001939

 $V_{TM} = A + Bln (I_T) + C.I_T + D.\sqrt{I_T}$ 

C = 0.0001366

D = -0.01259

these values are valid for  $T_j = 125$ °C for  $I_T 500$ A to 6000A



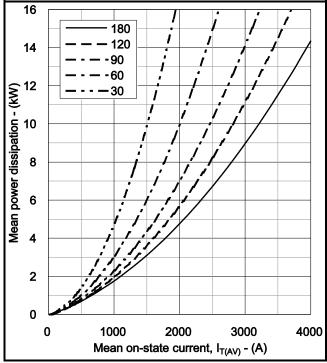


Fig.3 On-state power dissipation - sine wave

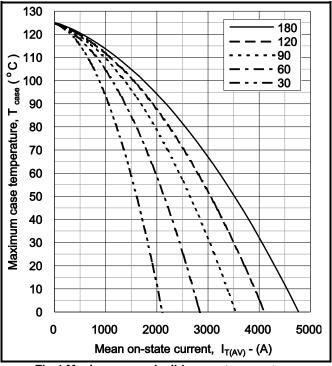


Fig.4 Maximum permissible case temperature, double side cooled – sine wave

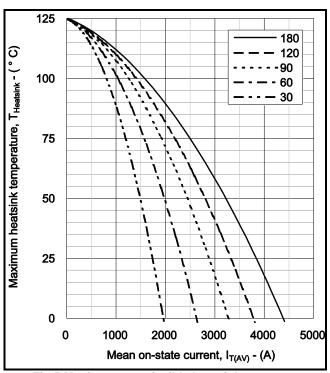


Fig.5 Maximum permissible heatsink temperature, double side cooled – sine wave

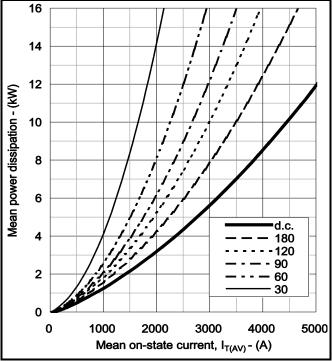


Fig.6 On-state power dissipation - rectangular wave



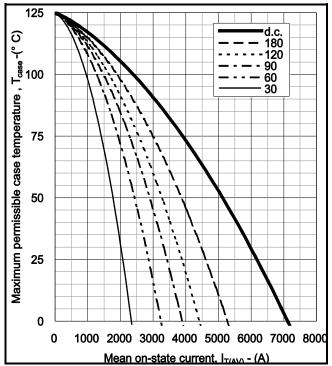


Fig.7 Maximum permissible case temperature, double side cooled – rectangular wave

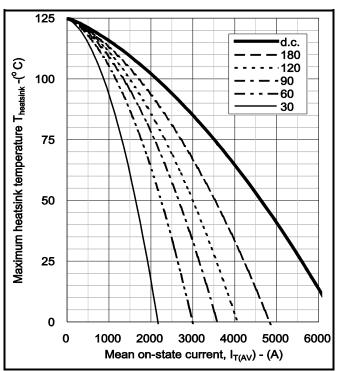
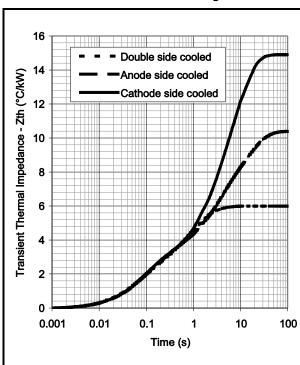


Fig.8 Maximum permissible heatsink temperature, double side cooled – rectangular wave



		1	2	3	4
Double side cooled	R <sub>i</sub> (°C/kW)	3.01541	1.048955	0.983519	0.983519
Double side cooled	T <sub>i</sub> (s)	0.703874	1.904794	0.059	0.059
Anode side cooled	R <sub>i</sub> (°C/kW)	3.156003	4.092806	1.556555	1.623962
	T <sub>i</sub> (s)	2.69023	13.79162	0.059	0.205916
Cathode side cooled	R <sub>i</sub> (°C/kW)	7.077369	3.483481	1.745839	2.634274
Callibue side cooled	T; (s)	6.648601	8.436484	1.762119	0.08069

$$Z_{th} = \sum_{i=1}^{i=4} [R_i \times (1 - \exp(T/T_i))]$$

### $\Delta R_{th(j-c)}$ Conduction

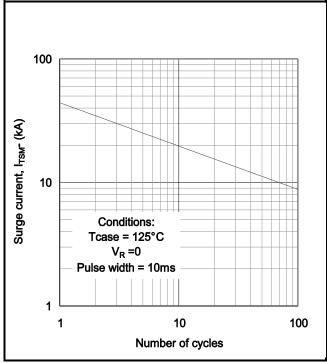
Tables show the increments of thermal resistance  $R_{\text{th(j-c)}}$  when the device operates at conduction angles other than d.c.

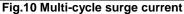
Double side cooling				Ar	node Side	Coo
	$\Delta Z_{th}(z)$				$\Delta Z_t$	<sub>h</sub> (z)
θ°	sine.	rect.	Ī	θ°	sine.	- n
180	0.44	0.31	Ī	180	0.42	0
120	0.49	0.43	I	120	0.47	C
90	0.55	0.49		90	0.52	O
60	0.60	0.55		60	0.57	O
30	0.64	0.61		30	0.61	O
15	0.66	0.64	I	15	0.62	C

Cath	node Sided Cooling				
	$\Delta Z_{th}(z)$				
θ°	sine.	rect.			
180	0.42	0.30			
120	0.47	0.41			
90	0.52	0.46			
60	0.57	0.52			
30	0.60	0.58			
15	0.62	0.60			

Fig.9 Maximum (limit) transient thermal impedance - junction to case (°C/kW)







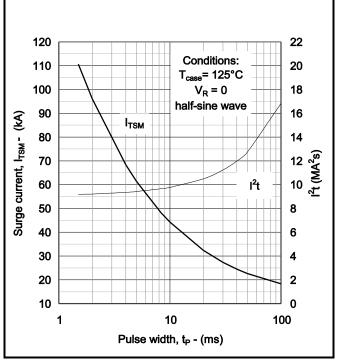


Fig.11 Single-cycle surge current

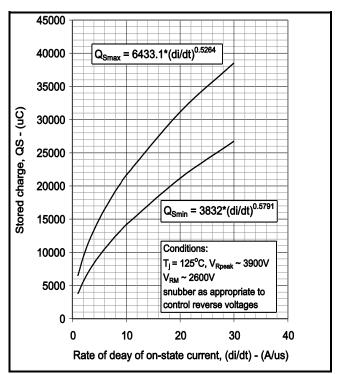


Fig.12 Stored charge

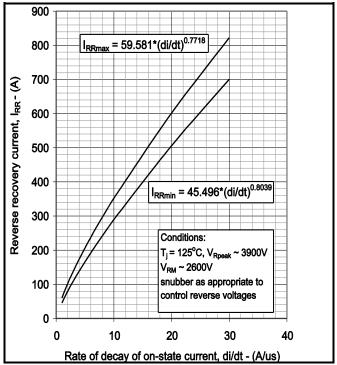


Fig.13 Reverse recovery current

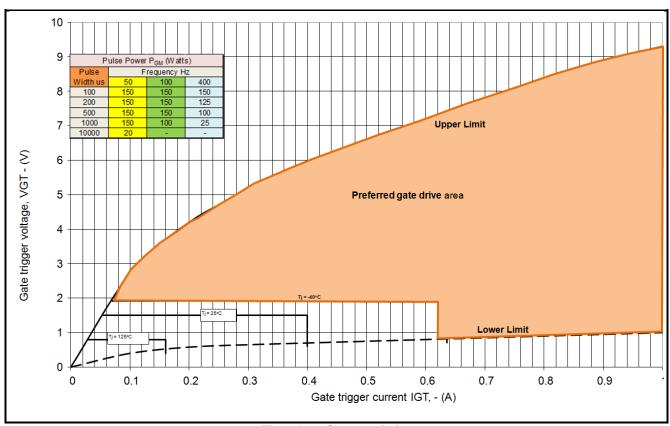


Fig14 Gate Characteristics

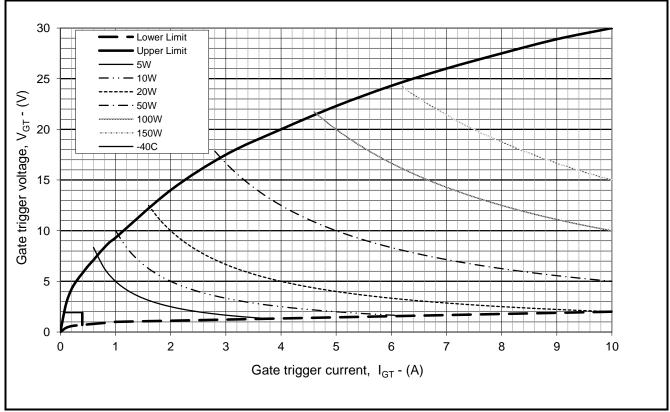


Fig. 15 Gate characteristics



# **PACKAGE DETAILS**

For further package information, please contact Customer Services. All dimensions in mm, unless stated otherwise. DO NOT SCALE.

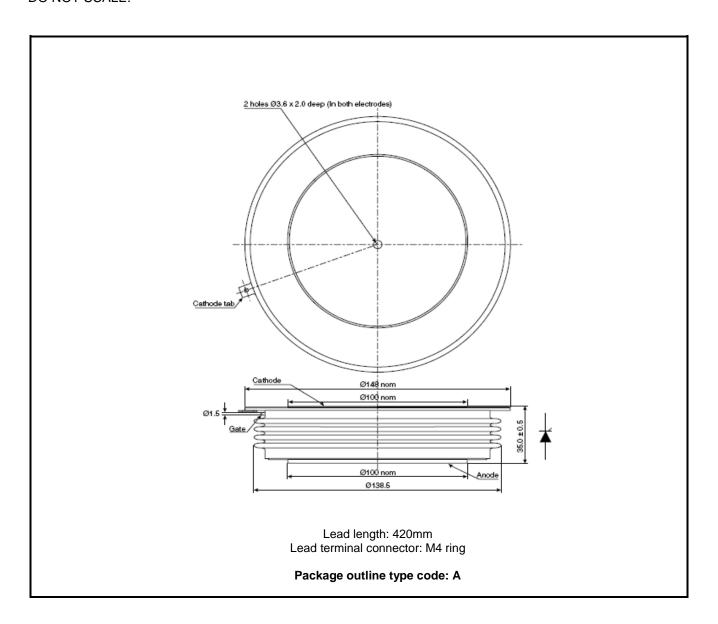


Fig.16 Package outline





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